

GENERAL DESCRIPTION

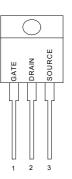
This advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

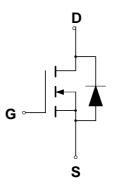
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} and V_{DS}(on) Specified at Elevated Temperature

PIN CONFIGURATION

TO-220 Front View



SYMBOL



N-Channel MOSFET

ORDERING INFORMATION

Part Number	Package
CMT10N10N220	TO-220

ABSOLUTE MAXIMUM RATINGS

Rating		Value	Unit
Drain to Current – Continuous		10	А
- Pulsed	I _{DM}	35	
Gate-to-Source Voltage – Continue	V_{GS}	±20	V
 Non-repetitive 	V_{GSM}	±40	V
Total Power Dissipation	PD	40	W
Derate above 25°C		0.32	W/°C
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C
Single Pulse Drain-to-Source Avalanche Energy $-$ T _J = 25 $^\circ\!{ m C}$	E _{AS}	69	mJ
$(V_{DD}$ = 100V, V_{GS} = 10V, I_L = 10A, L = 1.38mH, R_G = 25 Ω)			
Thermal Resistance – Junction to Case	θ _{JC}	3.13	°C/W
 Junction to Ambient 	θ _{JA}	100	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C



ELECTRICAL CHARACTERISTICS

Unless otherwise specified, T_J = 25 $^\circ\!\mathrm{C}$.

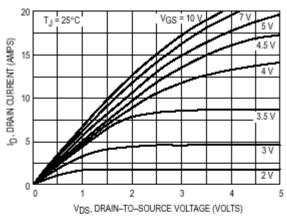
			CMT10N10			
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	100			V
$(V_{GS} = 0 V, I_D = 250 \mu A)$						
Drain-Source Leakage Current		I _{DSS}				μA
$(V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V})$					25	
$(V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125^{\circ}\text{C})$					100	
Gate-Source Leakage Current-Forward		I _{GSSF}			100	nA
$(V_{gsf} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Reverse		I _{GSSR}			100	nA
$(V_{gsr} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	1.0	1.45	2.0	V
$(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$						
Static Drain-Source On-Resistance (V_{GS} :	= 5.0 V, I _D = 5.0A) *	R _{DS(on)}			0.18	Ω
Drain-Source On-Voltage (V _{GS} = 5.0 V)		V _{DS(on)}		1.85	2.6	V
(I _D = 10 A)						
Forward Transconductance (V_{DS} = 50 V,	_D = 5.0A) *	g _{FS}	3.5			mhos
Input Capacitance	$(V_{DS} = 25 V, V_{CS} = 0 V)$	C _{iss}		741	1040	pF
Output Capacitance	f = 1.0 MHz	Coss		175	250	pF
Reverse Transfer Capacitance		C _{rss}		18.9	40	pF
Turn-On Delay Time	(V _{DD} = 50 V. I _D = 10 A.	t _{d(on)}		11	20	ns
Rise Time	$(v_{DD} = 50 \text{ V}, I_D = 10 \text{ A},$ $V_{GS} = 5.0 \text{ V},$ $R_G = 9.1\Omega) *$	tr		74	150	ns
Turn-Off Delay Time		t _{d(off)}		17	30	ns
Fall Time		t _f		38	80	ns
Total Gate Charge	$(V_{DS} = 80 \text{ V}, I_D = 10 \text{ A}, V_{GS} = 5.0 \text{ V})^*$	Qg		9.3	15	nC
Gate-Source Charge		Q_gs		2.56		nC
Gate-Drain Charge		Q_gd		4.4		nC
Internal Drain Inductance		L _D		4.5		nH
(Measured from the drain lead 0.25" from	m package to center of die)					
Internal Drain Inductance	tance			7.5		nH
(Measured from the source lead 0.25"	rom package to source bond pad)					
SOURCE-DRAIN DIODE CHARACTERI	STICS					
Forward On-Voltage(1)	$(I_{S} = 10 \text{ A}, V_{GS} = 0 \text{ V},$	V _{SD}			1.5	V
Forward Turn-On Time	$(I_{S} = 10 \text{ A}, V_{GS} = 0 \text{ V},$ $d_{IS}/d_{t} = 100 \text{ A}/\mu\text{s})$	t _{on}		**		ns
Reverse Recovery Time	$u_{IS}/u_t = 100A/\mu S$	t _{rr}		124.7		ns

* Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%

** Negligible, Dominated by circuit inductance



TYPICAL ELECTRICAL CHARACTERISTICS





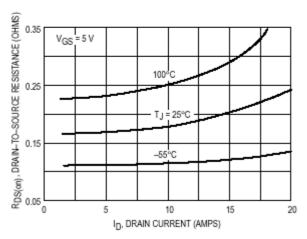
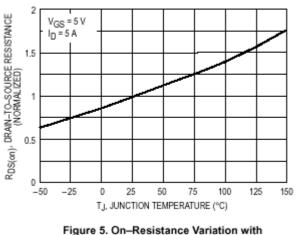


Figure 3. On–Resistance versus Drain Current and Temperature



Temperature

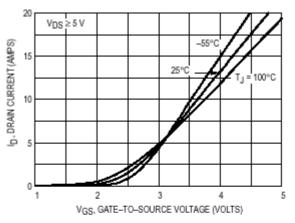


Figure 2. Transfer Characteristics

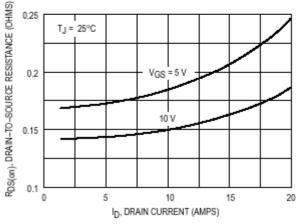


Figure 4. On–Resistance versus Drain Current and Gate Voltage

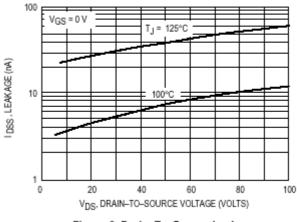
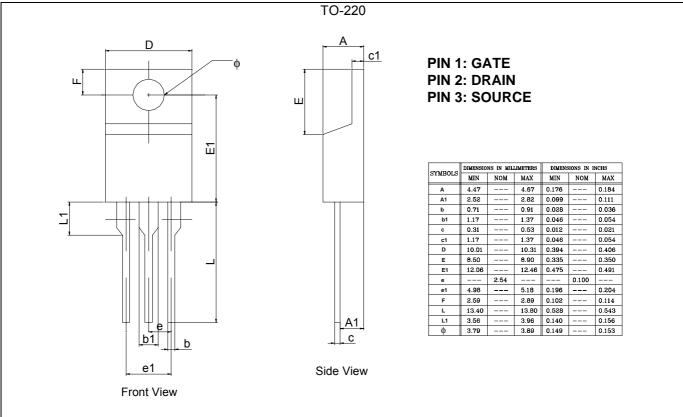


Figure 6. Drain–To–Source Leakage Current versus Voltage



PACKAGE DIMENSION





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